

Notice of References Cited

Application/Control No.

09/786,357

Applicant(s)/Patent Under
Reexamination
CHOI ET AL.

Examiner

Tung X Nguyen

Art Unit

2829

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,243,164 /	06-2001	Baldwin et al.	356/237.1
	B	US-6,055,055 /	04-2000	Toh, Peng Seng	250/559.46
	C	US-5,138,180 /	08-1992	Yamanaka, Kazuyuki	250/559.07
	D	US-6,005,965 /	12-1999	Tsuda et al.	250/559.08
	E	US-5,956,134 /	09-1999	Roy et al.	348/126
	F	US-6,160,906 /	12-2000	Lehnen et al.	348/131
	G	US-6,242,756 /	06-2001	Toh et al.	250/559.34
	H	US-6,088,108 /	07-2000	Toh et al.	356/237.1
	I	US-6,307,210 /	10-2001	Suzuki et al.	250/559.08
	J	US-6,072,898 /	06-2000	Beatty et al.	250/559.34
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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